



### P-Channel -30V (D-S) MOSFET

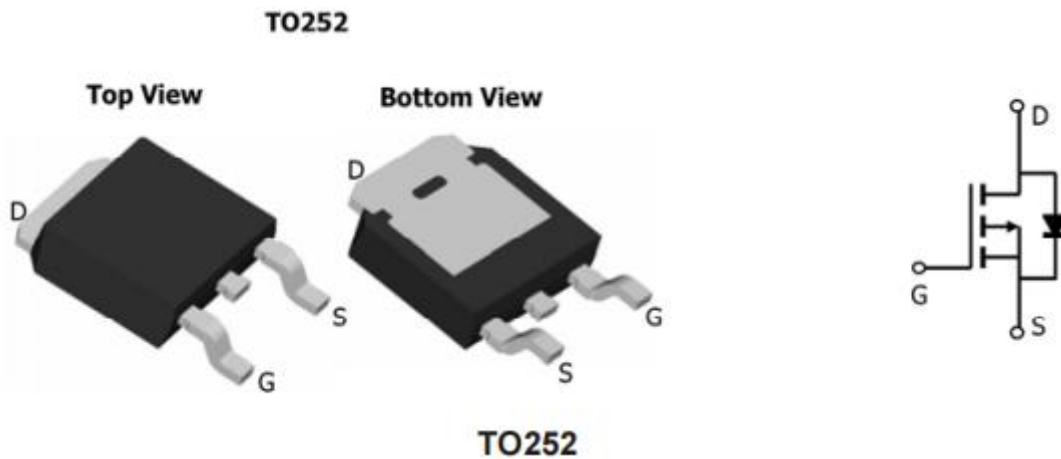
● **FEATURES**

- $R_{DS(ON)} \leq 13m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} \leq 17m\Omega @ V_{GS} = -4.5V$
- high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

● **GENERAL DESCRIPTION**

The LSP51 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

● **PIN CONFIGURATION**



● **Absolute Maximum Ratings** ( $T_A = 25^\circ C$  Unless Otherwise Noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	-35	A
Pulsed Drain Current	$I_{DM}$	-50	A
Maximum Power Dissipation	$P_D$	35	W
Derating factor		0.28	W/ $^\circ C$
Single pulse avalanche energy (Note 5)	$E_{AS}$	300	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 150	$^\circ C$

\* The device mounted on 1in<sub>2</sub> FR4 board with 2 oz copper



● **Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-31	-33	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-30V, V_{GS}=0V$	-	-	1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
<b>On Characteristics</b> (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1	-1.6	-2.2	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-10A$ $V_{GS}=-4.5V, I_D=-10A$	-	9 13	13 17	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=-10V, I_D=-15A$	-	20	-	S
<b>Dynamic Characteristics</b> (Note4)						
Input Capacitance	$C_{iss}$	$V_{DS}=-15V, V_{GS}=0V, F=1.0\text{MHz}$	-	3250	-	PF
Output Capacitance	$C_{oss}$		-	605	-	PF
Reverse Transfer Capacitance	$C_{rss}$		-	565	-	PF
<b>Switching Characteristics</b> (Note 4)						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=-15V, I_D=-10A$ $V_{GS}=-10V, R_{GEN}=6\Omega$	-	13	-	nS
Turn-on Rise Time	$t_r$		-	12	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	50	-	nS
Turn-Off Fall Time	$t_f$		-	14	-	nS
Total Gate Charge	$Q_g$	$V_{DS}=-15V, I_D=-10A,$ $V_{GS}=-10V$	-	84	-	nC
Gate-Source Charge	$Q_{gs}$		-	11.7	-	nC
Gate-Drain Charge	$Q_{gd}$		-	25	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage(Note 3)	$V_{SD}$	$V_{GS}=0V, I_S=-10A$	-	-0.85	-1.2	V
Diode Forward Current(Note 2)	$I_S$		-	-	-50	A
Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}, I_F = -10A$ $di/dt = 100A/\mu\text{s}$ (Note3)	-	-	45	nS
Reverse Recovery Charge	$Q_{rr}$		-	-	43	nC
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Note:

a: Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$

b: FORSEMI reserves the right to improve product design, functions and reliability without notice.



● TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

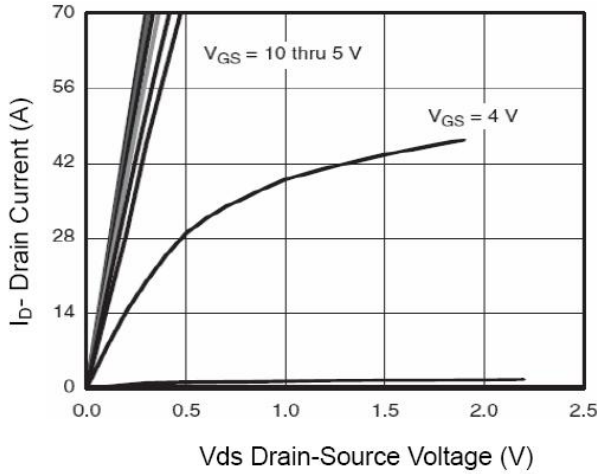


Figure 1 Output Characteristics

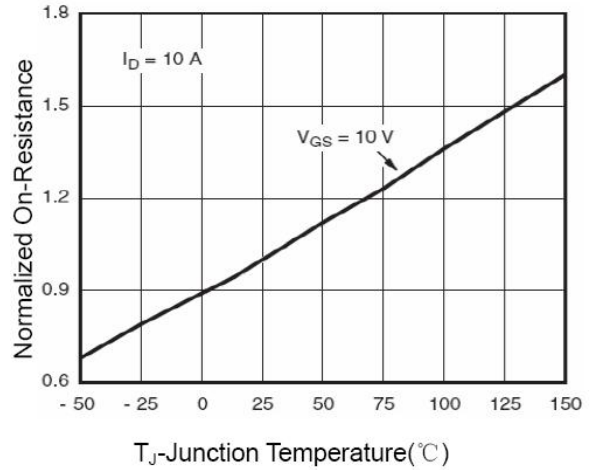


Figure 4  $R_{dson}$ -Junction Temperature

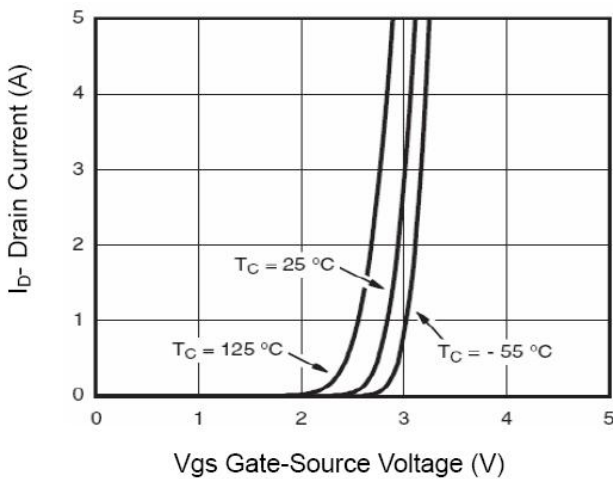


Figure 2 Transfer Characteristics

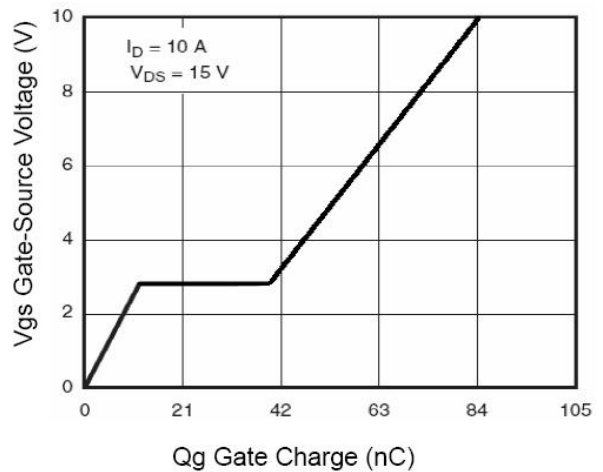


Figure 5 Gate Charge

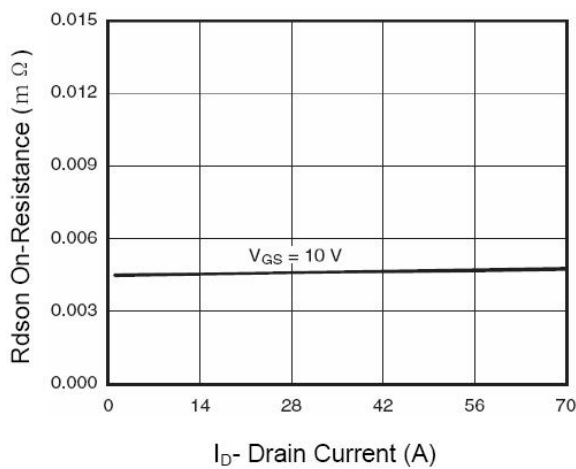


Figure 3  $R_{dson}$ - Drain Current

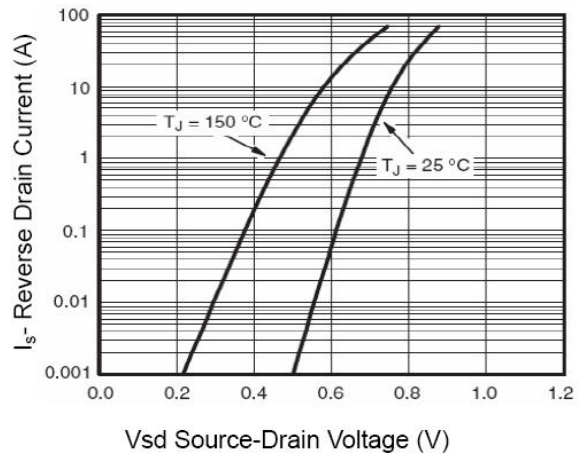
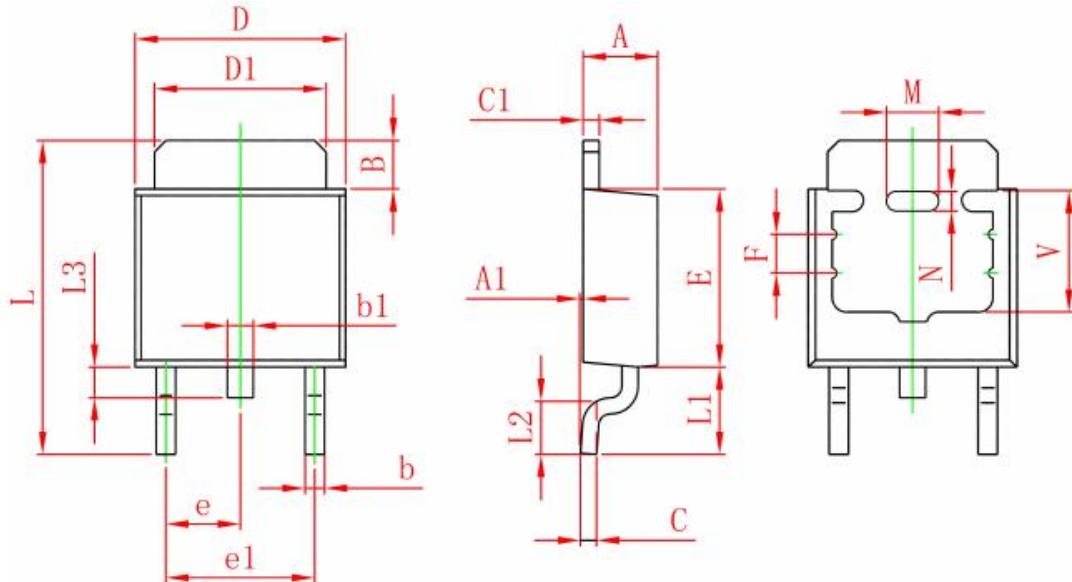


Figure 6 Source- Drain Diode Forward



● PACKAGE TO252



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
B	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
c	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
e	2.300 TYP.		0.091 TYP.	
e1	4.500	4.700	0.177	0.185
F	1.200REF.		0.047REF.	
M	1.600REF.		0.063REF.	
N	0.450REF.		0.018REF.	
L	9.500	9.900	0.374	0.390
L1	2.550	2.900	0.100	0.114
L2	1.400	1.780	0.055	0.070
L3	0.600	0.900	0.024	0.035
V	3.800 REF		0.150 REF	